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# Fabrication of large-scale single-crystal bismuth telluride (Bi<sub>2</sub>Te<sub>3</sub>) nanosheet arrays by a single-step electrolysis process<sup>†</sup>

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Nanolizing of thermoelectric materials is one approach to reduce the thermal conductivity and hence enhance the figure of merit. Bismuth telluride (Bi2Te3)-based materials have excellent figure of merit at room temperature. For device applications, precise control and rapid fabrication for the nanostructure of thermoelectric materials are essential issues. In the present study, we demonstrate a one-step electrolysis process to directly form Bi<sub>2</sub>Te<sub>3</sub> nanosheet arrays (NSAs) on the surface of bulk Bi2Te3 with controllable spacing distance and depth by tuning the applied bias and duration. The single sheet of NSAs reveals that the average thickness and electrical resistivity of single crystalline  $Bi_2Te_3$  in composition are 399.8 nm and 137.34  $\mu\Omega$  m, respectively. The formation mechanism of NSAs has been proposed. A 1.12% efficiency of quantum dot-sensitized solar cells with Bi2Te3 NSAs for counter electrode has been demonstrated, indicating that Bi2Te3 NSAs from top-down processing with a high ratio of surface area to volume are a promising candidate for possible applications such as thermoelectrics, dye-sensitized solar cells (DSSCs), and lithium-ion batteries.

# 1. Introduction

Two-dimensional materials<sup>1</sup> such as graphite,<sup>2</sup> h-BN,<sup>3</sup>  $MOS_2$ ,<sup>4</sup> and  $Bi_2Te_3$  <sup>5</sup> have the van der Waals gap in their crystal structure. Because of the weak van der Waals force, two-dimensional materials can be exfoliated to nanosheets by mechanical cleavage methods. Furthermore, metal ions can be intercalated into the van der Waals gap of these two-dimensional materials and thus form nanosheets.<sup>6</sup> In recent years,  $Bi_2Te_3$ -based

materials have attracted much attention due to their interesting physical properties. For example, nanostructured Bi<sub>2</sub>Te<sub>3</sub> with a high surface area has been used in dye-sensitized solar cells (DSSCs)7 and lithium-ion batteries.8 In addition, nanostructured Bi<sub>2</sub>Te<sub>3</sub> comes with a high thermoelectric figure of merit, namely ZT value, which is used to examine the thermoelectric performance of a thermoelectric material.9 The dimensionless figure of merit (ZT) can be given by  $ZT = (S^2 \sigma / \kappa)T$ where S,  $\sigma$ ,  $\kappa$ , and T are the Seebeck coefficient ( $\mu V K^{-1}$ ), electrical conductivity ( $\Omega^{-1}$  m<sup>-1</sup>), thermal conductivity (W m<sup>-1</sup>)  $K^{-1}$ ), and temperature (K), respectively. The ZT value of the nanostructured thermoelectric materials can be enhanced as thermal conductivity decreases as reported by both experimental<sup>10</sup> and theoretical<sup>11</sup> works. Therefore, it is an important issue to control the nanostructure of thermoelectric materials precisely.

The quintuple layer (QL) of the Bi<sub>2</sub>Te<sub>3</sub> consists of five monoatomic sheets (Te<sup>(1)</sup>–Bi–Te<sup>(2)</sup>–Bi–Te<sup>(1)</sup>), which are obtained by mechanical exfoliation or metal ion intercalation. Significantly decreased thermal conductivity of the QL of Bi2Te3 was observed.12 For high production yield and size uniformity of Bi<sub>2</sub>Te<sub>3</sub> nanosheets, hydrothermal synthesis and the electrochemical method are suitable methods for mass production.9,13 Although nanoplates, nanowires, nanotubes, and nanodots can be obtained by a hydrothermal method, a complicated device fabrication process is needed. In contrast to the hydrothermal method, the electrochemical method is a proper way to achieve mass production for thermoelectric device applications. For example, a large area of arranged Bi2Te3 nanowires was obtained by electrodepositing Bi<sub>2</sub>Te<sub>3</sub> into an anodic aluminum oxide (AAO) template with enhanced thermoelectric properties.13 However, post-treatments such as removal of AAO or transfer processing of arranged Bi2Te3 NWs for device applications may be needed.

To the best of our knowledge, rapid fabrication of a large scale  $Bi_2Te_3$  nanostructure has not yet been explored. The electrochemical method is a non-vacuum process and comes with advantages of large scale and low-cost fabrication. In this

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regard, we demonstrate a one-step electrochemical method to fabricate large-scale single-crystal  $Bi_2Te_3$  nanosheet arrays (NSAs) on the surface of bulk  $Bi_2Te_3$ . We have found that the area of  $Bi_2Te_3$  NSAs depends on the plane directions of  $Bi_2Te_3$ grains and the depth of  $Bi_2Te_3$  NSAs relies on the applied bias and duration. Phase structures and microstructures were characterized by X-ray diffraction, Raman spectroscopy, and transmission electron microscopy (TEM). In addition, the physical properties, such as thickness and resistivity, of single  $Bi_2Te_3$  nanosheets were measured and investigated in detail. A formation mechanism of NSAs has been proposed. Finally, the possible replacement of counter electrodes for DSSCs has been demonstrated.

# 2. Experimental section

#### Fabrication of Bi2Te3 NSAs

Bismuth (99.99 wt%, ADMAT) and tellurium (99.999 wt%, ADMAT) were used without further purification. Dilute nitric acid with a pH level of 1.2 was used as an electrolyte in the onestep electrochemical method with a three-electrode system for bias control. Because of compensation for evaporation of Te at high-temperature processing, additional Te (3 wt%) was added for the synthesis of the stoichiometric Bi<sub>2</sub>Te<sub>3</sub> compound. The weighed Bi and Te ingots were sealed in an evacuated quartz tube and annealed in a furnace at 850 °C for 48 h for synthesis of bulk Bi<sub>2</sub>Te<sub>3</sub>. Subsequently, the synthesized bulk Bi<sub>2</sub>Te<sub>3</sub> samples were sliced into circular disks with 1 cm in diameter and 3 mm in thickness. The polished bulk Bi2Te3 was used as a working electrode in which the mercury/mercury chloride (Hg/Hg<sub>2</sub>Cl<sub>2</sub>) electrode and platinum electrode were used as the reference electrode and counter electrode, respectively. The Bi<sub>2</sub>Te<sub>3</sub> NSAs with a periodic spacing distance of  $\sim 1 \ \mu m$  and tens of micrometers in depth were formed while various biases were applied for a few seconds to a few minutes.

#### **Device fabrication**

For the electrical measurements, the  $Bi_2Te_3$  nanosheet was put on a 50 nm thick  $SiO_2/Si$  substrate, followed by dropping the sample into diluted nitric acid to remove the native oxide. A 150 nm thick Ni metal layer was deposited by electron beam deposition as electrodes and defined by a photolithography process. For the CdSe QD-SSC fabrication, the  $TiO_2$  films were prepared by screen printing of  $TiO_2$  paste on FTO glass and sintering to form  $TiO_2$  mesoporous electrode. Chemical bath deposition was used to assemble CdSe QDs onto the  $TiO_2$ electrode, and then the  $TiO_2/CdSe$  electrode was sandwiched with  $Bi_2Te_3$  NSAs, pure FTO, and Pt as counter electrodes for further photovoltaic property measurements after injecting the polysulfide as an electrolyte. The active area of the cell was  $0.16 \text{ cm}^2$ .

#### Characterization

The crystallization and compositions of  $Bi_2Te_3$  were confirmed by X-ray diffraction (Shimadzu XRD 6000, CuK $\alpha$  radiation with a wavelength of 0.154 nm) and micro-Raman spectrometry (632.8 nm He–Ne laser with a laser intensity of 2 mW). Scanning electron microscopy (JSM 6500-F, JOEL operated at 15 kV with a resolution of 3.0 nm) and field-emission transmission electron microscopy (JEM-3000F, JEOL operated at 300 kV with a point-to-point resolution of 0.17 nm) were used to obtain the micro-structures and compositions. The electrical properties were measured using a Agilent B1500A semiconductor parameter analyzer at room temperature.

# 3. Results and discussion

Fig. 1 shows a schematic of how we fabricated Bi2Te3 NSAs with a periodic spacing distance of  $\sim 1 \,\mu m$  and tens of micrometers in depth at various biases for a few seconds to a few minutes. Bulk Bi<sub>2</sub>Te<sub>2</sub> was first prepared by sintering Bi and Te powders together, and then as-prepared bulk Bi2Te3 was polished until the surface appeared to have a metallic luster as shown in Fig. 1(a). Fig. 1(b) shows a schematic of the three-electrode system, which was used to fabricate Bi2Te3 NSAs. The polished Bi<sub>2</sub>Te<sub>3</sub> bulk was used as a working electrode. The mercury/ mercury chloride (Hg/Hg<sub>2</sub>Cl<sub>2</sub>) electrode and platinum electrode were used as the reference electrode and counter electrode, respectively. After applying a negative bias on the working electrode, Bi2Te3 NSAs were formed on the surface of bulk  $Bi_2Te_3$  as shown in Fig. 1(c). The corresponding scanning electron microscopy (SEM) image is shown in Fig. 1(d), in which we could observe Bi2Te3 NSAs formed on the allowed plane direction grains in the upper part and lower-left part. Note that no Bi<sub>2</sub>Te<sub>3</sub> NSAs were formed on the forbidden plane direction grains in the lower-right part. The inset shows a higher magnification image of a single Bi<sub>2</sub>Te<sub>3</sub> layer captured from the rectangular area in Fig. 1(d).

After the electrochemical treatment, the bulk  $Bi_2Te_3$  bulk was immersed in deionized water to remove the electrolyte. The



Fig. 1 Schematics of the experimental flow chart and SEM images. (a) Bulk  $Bi_2Te_3$ . (b) The three-electrode system. (c)  $Bi_2Te_3$  NSAs. (d) SEM image of  $Bi_2Te_3$  NSAs and a higher magnification image (inset).

Bi<sub>2</sub>Te<sub>3</sub> NSAs coincided with rhombohedral Bi<sub>2</sub>Te<sub>3</sub> (JCPDS 89-4302) in the XRD spectrum as well as the bulk Bi<sub>2</sub>Te<sub>3</sub> without formation of NSAs as shown in Fig. 2(a). Moreover, the single Bi<sub>2</sub>Te<sub>3</sub> sheet was examined by using direct sonication of Bi<sub>2</sub>Te<sub>3</sub> NSAs in ethanol for comparison. The corresponding Raman spectra and transmission electron microscopy (TEM) image of the single  $Bi_2Te_3$  sheet are shown in Fig. 2(b)-(d). For the Raman spectra of a single Bi<sub>2</sub>Te<sub>3</sub> sheet, two main peaks at 102.4 and 133.2 cm<sup>-1</sup> were observed, which are attributed to optical modes of 2Eg and 2A1g, respectively.14 These two main optical mode peaks are consistent with the Raman spectra of the pristine Bi<sub>2</sub>Te<sub>3</sub> bulk (Fig. 2(b)). The Fig. 2(c) shows a TEM image of a Bi<sub>2</sub>Te<sub>3</sub> sheet. The dark lines observed in the Bi<sub>2</sub>Te<sub>3</sub> sheet are probably due to the dislocations inside. The inset in Fig. 2(c) shows the corresponding selected area diffraction pattern (SAD). Obviously, symmetric spots indicate a single crystalline feature of the Bi<sub>2</sub>Te<sub>3</sub> sheet. According to zone axis of the electron diffraction pattern, the plane direction of the Bi<sub>2</sub>Te<sub>3</sub> sheet is (001), which is very important for understanding the formation mechanism of Bi2Te3 NSAs. The high-resolution TEM (HRTEM) image shown in Fig. 2(d) is in agreement with the Bi<sub>2</sub>Te<sub>3</sub> (110) plane, where a lattice spacing of 0.218 nm was indexed.

Fig. 3(a) shows that the unit cell of the  $Bi_2Te_3$  consisted of fifteen monoatomic sheets of bismuth and tellurium atoms in the rhombohedral crystalline structure. The bonding states between  $Bi-Te^{(1)}$  and  $Bi-Te^{(2)}$  are different and are attributed to ionic and covalent bonds, respectively. It is reported by Drabble and Goodman that these bonds are much stronger than the van der Waals force  $(Te^{(1)}-Te^{(1)})$ .<sup>15</sup> To shed light on the formation mechanism of the  $Bi_2Te_3$  NSAs, the *ex situ* formation of  $Bi_2Te_3$ 



Fig. 2 Material analysis for  $Bi_2Te_3$  NSAs. (a) XRD spectra of bulk  $Bi_2Te_3$  w/ and w/o NSAs. (b) Raman spectra of a  $Bi_2Te_3$  nanosheet and bulk  $Bi_2Te_3$ . (c) TEM image of a  $Bi_2Te_3$  nanosheet. The inset shows the corresponding diffraction pattern. (d) High-resolution TEM image of  $Bi_2Te_3$  nanosheet taken from (c).

NSAs was observed at the applied bias of -2 V with different duration of 5, 15, and 30 s as shown in Fig. 3(b). The corresponding schematics of the formation processes of Bi2Te3 NSAs are also shown in Fig. 3(c). With increasing duration, the bulk Bi<sub>2</sub>Te<sub>3</sub> was etched away and formed Bi<sub>2</sub>Te<sub>3</sub> NSAs during the electrolysis process. The reactivity sites of Bi2Te3 under applied bias can be examined by the Bi-Te bond energy. Kaviany and coworkers reported the bond energies of Te<sup>(1)</sup>-Bi, Te<sup>(2)</sup>-Bi, and Te<sup>(1)</sup>-Te<sup>(1)</sup> in Bi<sub>2</sub>Te<sub>3</sub> to be 0.974, 0.5801, and 0.0691 eV, respectively, by using computational methods.<sup>16</sup> As seen in Fig. 3(a), a Te<sup>(1)</sup> atom binds with three Bi and three Te<sup>(1)</sup> atoms. As a result, it needs 3.1293 eV to release a Te<sup>(1)</sup> atom (for detailed calculation, please see the ESI $\dagger$ ). For a Te<sup>(2)</sup> atom binding with six Bi atoms, it needs 3.4806 eV to release a Te<sup>(2)</sup> atom (for detailed calculation, please see the ESI<sup>†</sup>). However, it needs 4.6623 eV to release a Bi atom from three Bi-Te<sup>(1)</sup> bonds and three Bi-Te<sup>(2)</sup> bonds (for detailed calculation, please see the ESI<sup>†</sup>). Therefore, the Te<sup>(1)</sup> atom is the easiest to be removed because of its weak bonding energy. Besides, the distance between two monoatomic sheets of  $Te^{(1)}-Te^{(1)}$  is 2.598 Å, and the diameter of a hydrogen atom can be considered as two times the Bohr radius (1.058 Å), which is smaller than the gap of the  $Te^{(1)}-Te^{(1)}$ .<sup>17</sup> Therefore, hydrogen ions can be easily inserted into the gap of the Te<sup>(1)</sup>-Te<sup>(1)</sup> and thus react with Te<sup>(1)</sup> atoms to produce H<sub>2</sub> and H<sub>2</sub>Te gases during the electrolysis process. For better understanding, we designed an experiment to prove the existence of H<sub>2</sub>Te gas by observing the H<sub>2</sub>Te-derived tellurium blade on the surface of a suspended silicon substrate (details in ESI<sup>†</sup>). Once Te<sup>(1)</sup> atoms are etched, the Bi<sub>2</sub>Te<sub>3</sub> NSAs can be formed along the (001) surface of the bulk Bi2Te3. The etching processes of Bi2Te3 are shown in Fig. 3(c).

To understand the spacing control of the  $Bi_2Te_3$  NSAs, different biases were applied, for which the total charge flux for each applied bias was fixed. The spacing distances of  $Bi_2Te_3$ NSAs as a function of various applied biases were plotted as shown in Fig. 4(a). The electrolysis parameters and SEM images of the  $Bi_2Te_3$  NSAs for various applied biases are shown in Table 1 and Fig. 4(b)–(f), respectively. Obviously, the spacing distance is slightly decreased as the applied bias increases, suggesting that more reaction sites are created under the larger applied bias. The corresponding relationship between spacing distance and applied bias could be described by the following fitted curve:

$$y = -0.161 \times \ln(-x) + 1.4333$$

where *y* is the spacing distance and *x* is the applied bias. To measure the electrical properties of  $Bi_2Te_3$  nanosheets, a conventional photolithography technique was used to prepare two-terminal devices, and the corresponding thicknesses of the  $Bi_2Te_3$  nanosheets were measured by atomic force microscopy (AFM). Then, the measured thickness of the  $Bi_2Te_3$  nanosheet was used for resistivity calculation as shown in Fig. 5, the inset of which shows the corresponding device configuration. Consequently, the average thickness and electrical resistivity of the  $Bi_2Te_3$  nanosheets are ~399.8 nm and ~137.34  $\mu\Omega$  m, respectively. The electrical resistivity of the  $Bi_2Te_3$  nanosheets is



Fig. 3 Schematic of the mechanism of Bi<sub>2</sub>Te<sub>3</sub> NSA formation. (a) Unit cell of Bi<sub>2</sub>Te<sub>3</sub>. (b) Formation schematic of Bi<sub>2</sub>Te<sub>3</sub> NSAs at different steps and corresponding SEM images. (c) Schematic of how the hydrogen ion reacts with Bi<sub>2</sub>Te<sub>3</sub> and forms Bi<sub>2</sub>Te<sub>3</sub> NSAs.



Fig. 4 (a) Spacing distances of Bi<sub>2</sub>Te<sub>3</sub> NSAs under different applied biases and (b-f) their corresponding SEM images. The top panels are low-magnification images, and the bottom panels are high-magnification images.

Table 1 Electrolysis parameters at various applied biases

Applied bias (voltage)	-2	-5	-10	-15	-20
Duration (s)	300	120	60	45	30

larger than that in a previous work<sup>18</sup> by one order of magnitude, which may be the result of contact resistance owing to twoterminal measurement and doping conditions during synthesis



Fig. 5 Electrical property statistics of Bi<sub>2</sub>Te<sub>3</sub> nanosheets and schematic of electronic device (inset)

of Bi<sub>2</sub>Te<sub>3</sub>.<sup>19</sup> These two reasons can result in an increased measured resistance of the Bi<sub>2</sub>Te<sub>3</sub> nanosheet.

Generally, platinum (Pt) is used as a counter electrode for quantum dot-sensitized solar cells (QD-SSCs). However, Pt is an expensive and rare material in the world. Some alternative materials for the counter electrode have been proposed, such as metal chalcogenide,<sup>20,21</sup> Au,<sup>22</sup> and carbon.<sup>23</sup> The metallic property due to a very low band gap of  ${\sim}0.15$  eV  $^{24}$  and matched electron affinity of ~4.125-4.525 eV 25 make Bi2Te3 NSAs a potential candidate as the counter electrode to replace Pt for possible application in QD-SSCs. To shed light on this part, Fig. (6) shows the current density-voltage (J-V) curves of CdSe QD-SSCs with Bi2Te3 NSAs, pure FTO, and Pt as counter electrodes under 1 sun illumination. The photovoltaic (PV) properties of these electrodes are listed in Table 2. As can be seen in



Fig. 6 J-V characteristic of CdSe QD-SSCs with three different counter electrodes (Bi<sub>2</sub>Te<sub>3</sub> NSAs, pure FTO, and Pt).

Table 2 Photovoltaic properties of QD-SSCs

Electrode	$V_{\rm oc}$ (V)	$J_{\rm sc}~({\rm mA~cm^{-2}})$	FF	$\eta$ (%)	Ref.
T'O KOLO, DI	0.60	7.04	0.44	4.04	ml in and
$11O_2/CdSe$ , Pt	0.62	7.31	0.41	1.84	This work
TiO <sub>2</sub> /CdSe, Pt	0.65	4.65	0.31	0.90	26
TiO <sub>2</sub> /CdSe, Pt	0.68	6.03	0.39	1.60	26
TiO <sub>2</sub> /CdSe, Pt	0.46	8.70	0.31	1.24	27
TiO <sub>2</sub> /CdSe, Pt	0.65	3.27	0.50	1.08	28
TiO <sub>2</sub> /CdSe, Pt	0.61	3.93	0.49	1.19	28
TiO <sub>2</sub> /CdSe,	0.58	6.89	0.28	1.12	This work
Bi <sub>2</sub> Te <sub>3</sub> NSAs					
TiO <sub>2</sub> /CdSe, FTO	0.57	2.20	0.14	0.18	This work

Table 2, the open-circuit voltage ( $V_{oc}$ ) of the Bi<sub>2</sub>Te<sub>3</sub> counter electrode is 0.581 V, which is lower than that of the Pt electrode by 0.035 V. The short-circuit current ( $J_{sc}$ ) of the Bi<sub>2</sub>Te<sub>3</sub> NSAs and Pt counter electrodes are 6.891 and 7.314 mA cm<sup>-2</sup>, respectively. Therefore, the PV conversion efficiency of the Bi<sub>2</sub>Te<sub>3</sub> NSAs as the counter electrode can reach 1.12%, which is better than that of the device using pure FTO as the electrode (0.18%) and comparable with that of Pt as the counter electrode (0.9–1.84%).

## 4. Conclusions

We have demonstrated a novel one-step electrolysis process for directly fabricating large-scale  $Bi_2Te_3$  NSAs. The composition and properties of  $Bi_2Te_3$  NSAs have been analyzed by XRD, Raman spectroscopy, SEM, TEM, and electrical measurements. The spacing distance and depth of  $Bi_2Te_3$  NSAs depend on the applied bias, current densities and bias duration. Our experimental results indicate that the spacing distance of  $Bi_2Te_3$ nanosheets is of 1 µm with a thickness of several hundred nanometers. Moreover, the  $Bi_2Te_3$  NSAs show potential for a wide variety of applications due to the high surface area to volume ratio. The formation mechanism of  $Bi_2Te_3$  NSAs was proposed as well. The  $Bi_2Te_3$  NSAs as counter electrodes of CdSe QD-SSCs with a PV conversion efficiency of 1.12% have been demonstrated. The proposed process may be used for the synthesis of other NSAs employing different materials such as  $Sb_2Te_3$  and  $MoSe_2$  in future.

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